



<p>Searched</p> 	<p>Application/Control No.</p> <p>10618343</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>UNO, KOUJI</p>
	<p>Examiner</p> <p>Kaplan, Hal I</p>	<p>Art Unit</p> <p>2836</p>


Class	SubClass	Date	Examiner
324	403	08/11/2006	HK
340	815.52	08/11/2006	HK
340	815.75	08/11/2006	HK

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Search Notes 	Application/Control No. 10618343	Applicant(s)/Patent Under Reexamination UNO, KOUJI
	Examiner Kaplan, Hal I	Art Unit 2836

Notes	Date	Examiner
EAST (US-PGPUB,USPAT,USOCR,EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	08/11/2006	HK

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